

# **MOSFET** – P-Channel, POWERTRENCH®

-150 V, -2.6 A, 1.2  $\Omega$ 

# **FDMC86265P**

# **General Description**

This P-Channel MOSFET is produced using onsemi's advanced POWERTRENCH process that has been optimized for the on-state resistance and yet maintain superior switching performance.

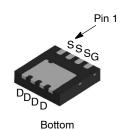
# **Features**

- Max  $r_{DS(on)} = 1.2 \Omega$  at  $V_{GS} = -10 \text{ V}$ ,  $I_D = -1 \text{ A}$
- Max  $r_{DS(on)} = 1.4 \Omega$  at  $V_{GS} = -6 \text{ V}$ ,  $I_D = -0.9 \text{ A}$
- Very Low RDS-On Mid Voltage P-Channel Silicon Technology Optimized for Low Qg
- This Product is Optimized for Fast Switching Applications as well as Load Switch Applications
- 100% UIL Tested
- These Devices are Pb-Free, Halide Free and are RoHS Compliant

# **Applications**

- Active Clamp Switch
- Load Switch





Top

WDFN8 3.3x3.3, 0.65P CASE 511DH

# MARKING DIAGRAM



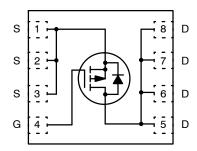
FDMC 86265P

Specific Device Code = Specific Device Code = Assembly Location

Lot Run Traceability Code

Date Code (Year and Week)

# **PIN ASSIGNMENT**



P-Channel MOSFET

### ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

# MOSFET MAXIMUM RATINGS (T<sub>A</sub> = 25°C unless otherwise noted)

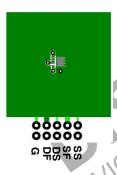
Symbol	Parameter			Rating	Unit
V <sub>DS</sub>	Drain to Source Voltage			-150	V
V <sub>GS</sub>	Gate to Source Voltage			±25	٧
I <sub>D</sub>	Drain Current	Continuous (Note 5)	T <sub>C</sub> = 25°C	-2.6	Α
		Continuous (Note 5)	T <sub>C</sub> = 100°C	-1.65	
		Continuous (Note 1a)	T <sub>A</sub> = 25°C	-1	
		Pulsed (Note 4)		-9	
E <sub>AS</sub>	Single Pulse Avalanche Energy (Note 3)		6	mJ	
P <sub>D</sub>	Power Dissipation $T_C = 25^{\circ}C$		16	W	
	Power Dissipation (Note 1a) T <sub>A</sub> = 25°C			2.3	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to + 150	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

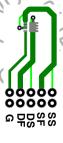
# THERMAL CHARACTERISTICS

Symbol	Parameter	N	Rating	Unit
Rejc	Thermal Resistance, Junction to Case	ME	7.5	°C/W
RθJA	Thermal Resistance, Junction to Ambient (Note 1a)	JOK N	53	

1.  $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a. 53°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b. 125°C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0%. 3. Starting T<sub>J</sub> = 25°C; P-ch: L = 3 mH, I<sub>AS</sub> = -2 A, V<sub>DD</sub> = -150 V, V<sub>GS</sub> = -10 V. 100% test al L = 0.1 mH, I<sub>AS</sub> = -9 A. 4. Pulsed Id please refer to Figure 11 and Figure 24 SOA graph for more details.
- 5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit		
OFF CHARACTERISTICS								
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-150	_	-	V		
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D$ = -250 μA, referenced to 25°C	-	-125	-	mV/°C		
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -120 \text{ V}, V_{GS} = 0 \text{ V}$	_	-	-1	μΑ		
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±100	nA		
ON CHARA	CTERISTICS							
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = -250 \mu A$	-2	-3.2	-4	V		
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = -250 $\mu$ A, referenced to 25°C	-	5	-	mV/°C		
r <sub>DS(on)</sub>	Static Drain to Source	V <sub>GS</sub> = -10 V, I <sub>D</sub> = -1 A		0.86	1.2	Ω		
	On Resistance	$V_{GS} = -6 \text{ V}, I_D = -0.9 \text{ A}$		0.95	1.4			
		V <sub>GS</sub> = -10 V, I <sub>D</sub> = -1 A, T <sub>J</sub> = 125°C	7-	1.53	2.2			
9FS	Forward Transconductance	$V_{DS} = -10 \text{ V}, I_D = -1 \text{ A}$	1	1.9	-	S		
DYNAMIC C	HARACTERISTICS		Mr.					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -75 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-01	158	210	pF		
C <sub>oss</sub>	Output Capacitance		267. X	16	25	pF		
C <sub>rss</sub>	Reverse Transfer Capacitance	JOE OF	17/2	0.7	5	pF		
Rg	Gate Resistance	WELD THE OF	0.1	3	7.5	Ω		
SWITCHING	CHARACTERISTICS	Mary 40 Me						
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = -75 \text{ V}, I_D = -1 \text{ A}, V_{GS} = -10 \text{ V},$	_	5.8	12	ns		
t <sub>r</sub>	Rise Time	$R_{GEN} = 6 \Omega$	_	2.2	10	ns		
t <sub>d(off)</sub>	Turn-Off Delay Time	$R_{GEN} = 6 \Omega$	_	8	16	ns		
t <sub>f</sub>	Fall Time		_	6.4	13	ns		
Q <sub>g(TOT)</sub>	Total Gate Charge	$V_{DD} = -75 \text{ V}, I_D = -1 \text{ A}, V_{GS} = 0 \text{ V to } -10 \text{ V}$	_	2.8	4	nC		
$Q_{gs}$	Total Gate Charge	$V_{DD} = -75 \text{ V}, I_D = -1 \text{ A}$	_	0.8	-	nC		
$Q_{gd}$	Gate to Drain "Miller" Charge		_	0.7	_	nC		
DRAIN-SOURCE DIODE CHARACTERISTICS								
V <sub>SD</sub>	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = -1 \text{ A (Note 2)}$	-	-0.87	-1.3	V		
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = -1 A, di/dt = 100 A/μs	_	50	80	ns		
$Q_{rr}$	Reverse Recovery Charge		_	78	124	nC		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

# TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)

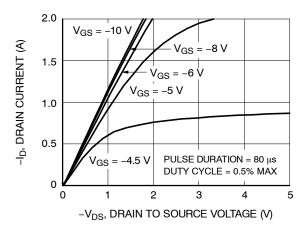


Figure 1. On Region Characteristics

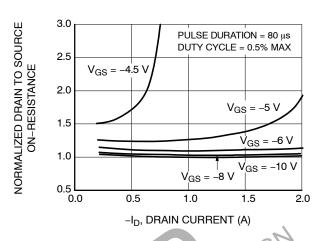


Figure 2. Normalized On–Resistance vs.

Drain Current and Gate Voltage

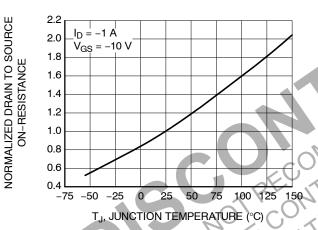


Figure 3. Normalized On Resistance vs. Junction Temperature

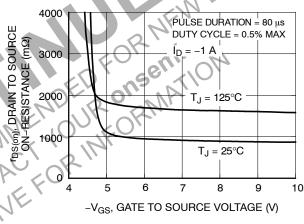


Figure 4. On-Resistance vs. Gate to Source Voltage

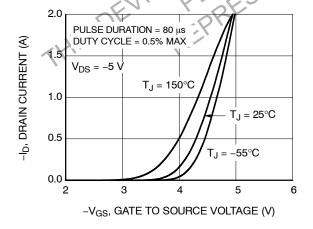


Figure 5. Transfer Characteristics

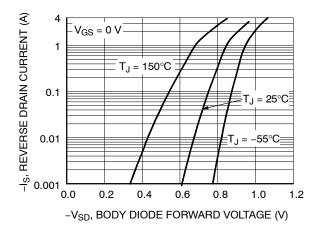


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

# TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

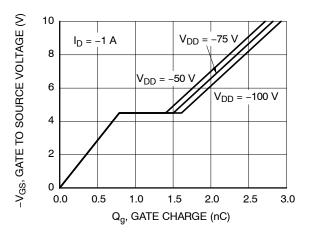


Figure 7. Gate Charge Characteristics

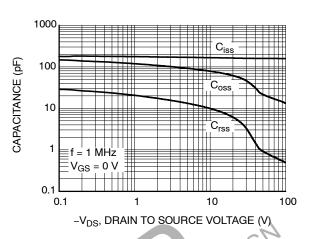


Figure 8. Capacitance vs. Drain to Source Voltage

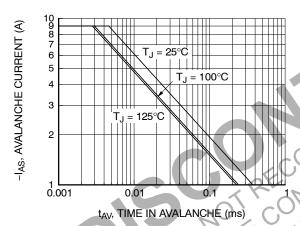


Figure 9. Unclamped Inductive Switching Capability

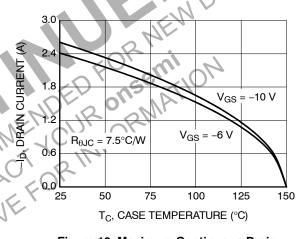


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

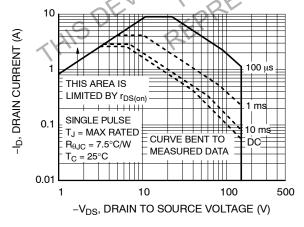


Figure 11. Forward Bias Safe Operating Area

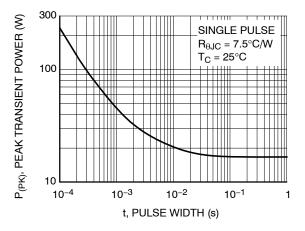


Figure 12. Single Pulse Maximum Power Dissipation

# TYPICAL CHARACTERISTICS (T<sub>.1</sub> = 25°C unless otherwise noted) (continued)

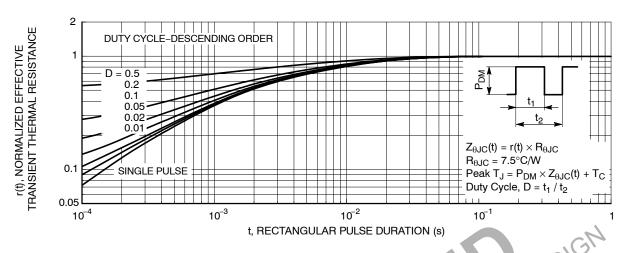


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

## **ORDERING INFORMATION**

Device         Device Marking         Package Type         Shipping           FDMC86265P         FDMC86265P         WDFN8 3.3x3.3, 0.65P (Pb-Free)         3000 / Tape 8           †For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Respecifications Brochure, BRD8011/D.         Respecifications and tape sizes, please refer to our Tape and Respecifications are sizes.	g <sup>†</sup>
(Pb-Free) †For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Re	
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<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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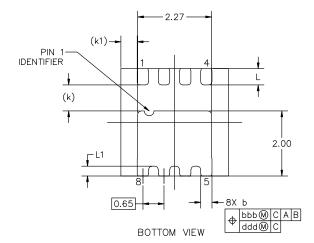
PIN 1

**IDENTIFIER** 

# WDFN-8 3.30x3.30x0.75, 0.65P CASE 511DH **ISSUE A**

aga C Ð Α В Ė

TOP VIEW // ccc C SEATING PLANE eee C Α1 Ċ (A3) SIDE VIEW

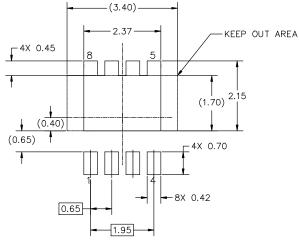


# NOTES:

# **DATE 04 DEC 2025**

- DIMENSIONING AND TOLERANCING
  AS PER ASME Y14.5M, 2018.
  CONTROLLING DIMENSION:
- MILLIMETERS.

MILLIMETERS						
DIM	MIN	NOM	MAX			
А	0.70	0.75	0.80			
A1	0.00	0.025	0.05			
А3	0.20 REF					
b	0.30	0.35	0.40			
D	3.30 BSC					
D2	2.22	2.27	2.32			
E	3.30 BSC					
E2	1.95	2.00	2.05			
е	0.65 BSC					
k	0.80 REF					
k1	0.50 REF					
L	0.45	0.50	0.55			
L1	0.25	0.30	0.35			
TOLERANCE FORM & POSITION						
aaa	0.05					
bbb	0.10					
ccc	0.10					
ddd	0.05					
eee	0.08					



# **GENERIC MARKING DIAGRAM\***

XXXX = Specific Device Code = Assembly Location

= Year WW = Work Week

XXXXX **AYWW** 

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

# RECOMMENDED MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques reference manual, SOLDERRM/D.

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DESCRIPTION:	WDFN-8 3.30x3.30x0.75, 0.65P		PAGE 1 OF 1		

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